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LIST OF REFERENCES CITED BY APPLICANT Sung Uk MOON, et al.							
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U.S. PATENT DOCUMENTS							
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		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO	
/AW/	AO	7-107032	04/21/1995	JAPAN (with English Abstract and Unedited Computer-Generated English translation)		х	
/AW/	AP	2002-124935	04/26/2002	JAPAN (with English Abstract and Unedited Computer-Generated English translation)		Х	
/AW/	AQ	2000-115051	04/21/2000	JAPAN (with English Abstract and Unedited Computer-Generated English translation)		Х	
/AW/	AR	2001-313604	11/09/2001	JAPAN (with English Abstract and Unedited Computer-Generated English translation)		X	
/AW/	AS	4-23525	01/27/1992	JAPAN (with English Abstract)		Х	
/AW/	AT	2004-112544	04/08/2004	JAPAN (with English Abstract and Unedited Computer-Generated English translation)		×	
/AW/	ΑU	2004-166190	06/10/2004	JAPAN (with English Abstract and Unedited Computer-Generated English translation)		х	
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
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Examiner		row Mondall/			Additional References sheet(s) attached		
Examiner /Andrew Wendell/ Date Considered 06/13/2007 *Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in							
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